

PC942 Series

High Power, Gate Drive DIP 8 pin *OPIC Photocoupler



■ Description

PC942 Series contains an IRED optically coupled to an OPIC chip.

It is packaged in a 8 pin DIP, available in SMT gullwing lead form option.

Input-output isolation voltage(rms) is 5.0kV, High speed response (t_{PHL},t_{PLH} : MAX. $5\mu s$) and CMR is MIN. $10kv/\mu s$.

■ Features

- 1. 8 pin DIP package
- 2. Double transfer mold package (Ideal for Flow Soldering)
- 3. Built-in base amplifier for inverter drive
- 4. High power (I_{O1}: MAX. 0.5A (DC)) (I_{O2P}: MAX. 2.0A (pulse))
- 5. High noise immunity due to high instantaneous common mode rejection voltage

(CM $_H$: MIN. –10 kV/ $\mu s,~CM_L$: MIN. 10 kV/ $\mu s)$

- 6. High speed response (t_{PHL},t_{PLH} : MAX. 5μs)
- 7. High isolation voltage between input and output (V_{iso(rms)}: 5.0 kV)

■ Agency approvals/Compliance

- Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. PC942)
- 2. Package resin: UL flammability grade (94V-0)

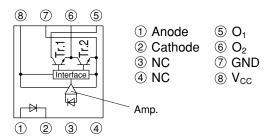
■ Applications

- 1. Inverter controlled air conditioners
- 2. Small capacity general purpose inverters

^{* &}quot;OPIC"(Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and a signal-processing circuit integrated onto a single chip.



■ Internal Connection Diagram

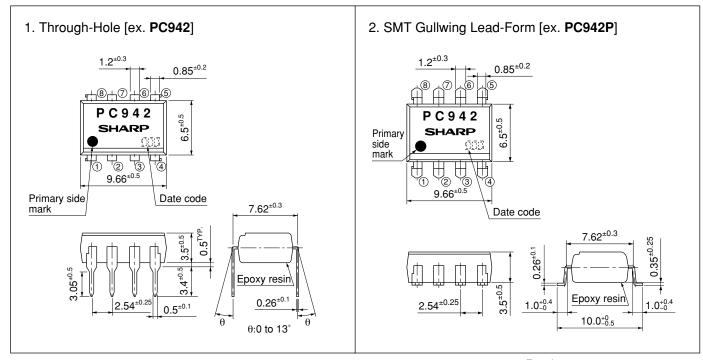


■ Truth table

Input	O ₂ Terminal output	Tr. 1	Tr. 2
ON	High level	ON	OFF
OFF	Low level	OFF	ON

■ Outline Dimensions

(Unit: mm)



Product mass: approx. 0.55g



Date code (3 digit)

1st digit				2nd digit		3rd digit	
Year of production				Month of production		Week of production	
A.D.	Mark	A.D	Mark	Month	Mark	Week	Mark
1990	A	2002	P	January	1	1st	1
1991	В	2003	R	February	2	2nd	2
1992	С	2004	S	March	3	3rd	3
1993	D	2005	T	April	4	4th	4
1994	Е	2006	U	May	5	5.6th	5
1995	F	2007	V	June	6		
1996	Н	2008	W	July	7		
1997	J	2009	X	August	8		
1998	K	2010	A	September	9		
1999	L	2011	В	October	0		
2000	M	2012	С	November	N		
2001	N	•	i	December	D		

repeats in a 20 year cycle

Country of origin Japan



■ Absolute Maximum Ratings

(Unless otherwise specified T_a=T_{opr})

				F-/
	Parameter	Symbol	Rating	Unit
Innut	*1 Forward current	I_F	25	mA
Input	*2 Reverse voltage	V_R	6	V
	Supply voltage	V_{CC}	18	V
	O ₁ output current	I_{O1}	0.5	A
	*3 O ₁ Peak output current	I_{O1P}	1.0	A
Output	O ₂ output current	I_{O2}	0.6	A
	*3 O ₂ Peak output current	I_{O2P}	2.0	A
	O ₁ output voltage	V_{O1}	18	V
	*4 Power dissipation	Po	500	mW
*5 Total	power dissipation	P _{tot}	550	mW
*6 Isolat	ion voltage	V _{iso (rms)}	5.0	kV
Opera	ating temperature	T_{opr}	-20 to +80	°C
Stora	ge temperature	T_{stg}	-55 to +125	°C
*7 Solde	ring temperature	T_{sol}	260	°C

The derating factors of a absolute maximum ratings due to ambient

■ Electro-optical Characteristics

(Unless otherwise specified $T_a=T_{opr}$)

	Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input		Eastward valtage	V_{F1}	$T_a=25^{\circ}C$, $I_F=5mA$	-	1.1	1.4	V
	Forward voltage		V_{F2}	$T_a=25$ °C, $I_F=0.2$ mA	0.6	0.9	_	V
Inj	Reverse current		I_R	$T_a=25^{\circ}C, V_R=3V$	-	ı	10	μΑ
		Terminal capacitance	C_{t}	$T_a=25$ °C, V=0, f=1kHz	-	30	250	pF
	Supply voltage		V_{CC}	ı	5.4	-	13	V
	O ₁ Low level output voltage		V_{O1L}	V_{CC} =6 V , I_{O1} =0.4 A , R_{L2} =10 Ω , I_{F} =5 mA	-	0.2	0.4	V
		O ₂ High level output voltage	$V_{\rm O2H}$	V_{CC} =6 V , I_{O2} =-0.4 A , I_{F} =5 mA	4.5	5.0	-	V
		O ₂ Low level output voltage	V_{O2L}	V_{CC} =6 V , I_{O2} =0.5 A , I_{F} =0	_	0.2	0.4	V
Output		O ₁ leak current	I_{O1L}	$V_{CC}=13V, I_{F}=0$	-	-	200	μΑ
Oni		O ₂ leak current	$I_{\rm O2L}$	V_{CC} =13 V , I_F =5 mA	-	-	200	μΑ
		High level supply current	Ι	$T_a=25$ °C, V=6V, $I_F=5$ mA	_	9	13	mA
		riigii ievei suppiy cuiteit	I_{CCH}	$V_{CC}=6V, I_F=5mA$	-	-	17	mA
		Low level supply current	I_{CCL}	$T_a=25^{\circ}C, V_{CC}=6V, I_F=0$	-	11	15	mA
	Low level supply current		1CCL	V_{CC} =6 V , I_F =0	-	-	20	mA
	*8	"Low→High"	${ m I_{FLH}}$	T_a =25°C, V_{CC} =6V, R_{L1} =5 Ω , R_{L2} =10 Ω	0.3	1.5	3.0	mA
		input threshold current	1FLH	V_{CC} =6 V , R_{L1} =5 Ω , R_{L2} =10 Ω	0.2	_	5.0	mA
		Isolation resistance	$R_{\rm ISO}$	T_a =25°C, DC500V, 40 to 60%RH	5×10 ¹⁰	10^{11}	-	Ω
cs	ime	"Low→High" propagation delay time	t_{PLH}		-	2	5	μs
risti	Response time	"High→Low" propagation delay time	t_{PHL}	$T_a=25^{\circ}C, \ V_{CC}=6V, I_F=5mA$	-	2	5	μs
acte	noas	Rise time	t_r	R_{L1} =5 Ω , R_{L2} =10 Ω	-	0.2	1	μs
Transfer characteristics	Res	Fall time	t_{f}		-	0.1	1	μs
fer (Instantaneous common mode		$T_a=25$ °C, $V_{CM}=600V(peak)$				
rans		rejection voltage CI		I_F =5mA, R_{L1} =470 Ω	-10	-	_	kV/μs
Ξ		(High level output)		$R_{L2}\text{=}1\text{k}\Omega,\Delta V_{O2H}\text{=}0.5V(MAX)$				
		Instantaneous common mode		$T_a=25$ °C, $V_{CM}=600V(peak)$				
		rejection voltage	CM_L	I_F =0, R_{L1} =470 Ω	10	_	_	kV/μs
		(Low level output)		R_{L2} =1 $k\Omega$, ΔV_{O2L} =0.5 $V(MAX)$				

^{*8} $\, I_{FLH} \,$ represents forward current when output goes from "Low" to "High"

temperature are shown in Fig.8

*2 T_a=25°C *3 Pulse width≤5µs, Duty ratio: 0.01

*4.5 The derating factors of a absolute maximum ratings due to ambient temperature are shown in Fig.8

AC for 1minute, 40 to 60 %RH, $T_a = 25^{\circ}$ C, f = 60Hz *7 For 10s



■ Model Line-up

Lead Form	Through-Hole	SMT Gullwing
Package	Sleeve	Taping
	50pcs/sleeve	1 000pcs/reel
Model No.	PC942	PC942P

Please contact a local SHARP sales representative to inquire about production status and Lead-Free options.



Fig.1 Test Circuit for O₁ Low Level Output Voltage

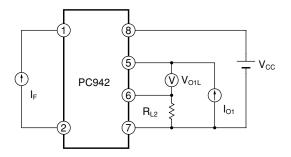


Fig.2 Test Circuit for O₂ High Level Output Voltage

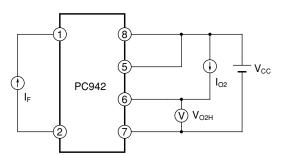


Fig.3 Test Circuit for O₁ Leak Current

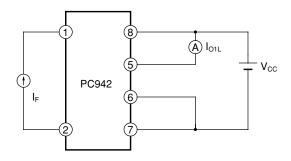


Fig.4 Test Circuit for O₂ Leak Current

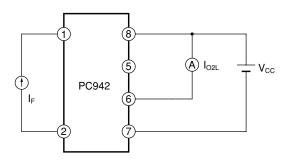


Fig.5 Test Circuit for "Low→High" Input Threshold Current

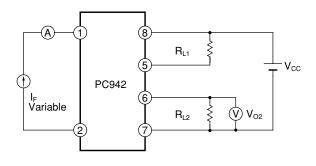


Fig.6 Test Circuit for Response Time

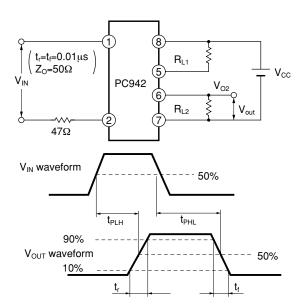
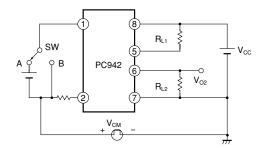




Fig.7 Test Circuit for Instantaneous Common Mode Rejection Voltage



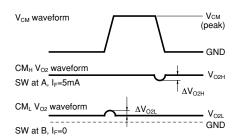


Fig.8 Forward Current vs. Ambient Temperature

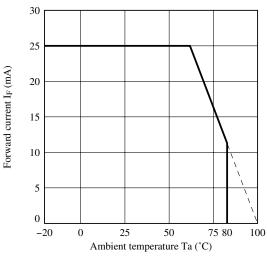


Fig.9 Power Dissipation vs. Ambient Temperature

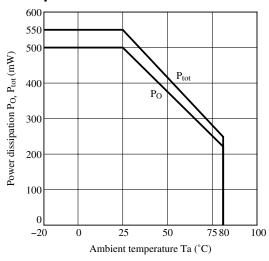


Fig.10 Forward Current vs. Forward Voltage

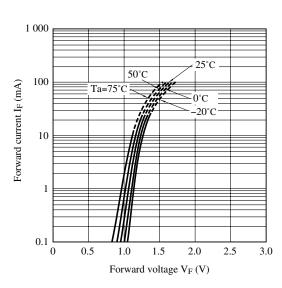


Fig.11 "Low→High" Relative Input Threshold Current vs. Supply Voltage

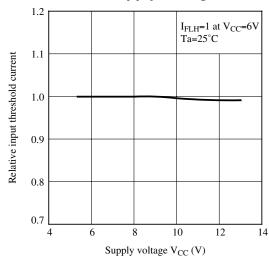




Fig.12 "Low→High" Relative Input Threshold Current vs. Ambient Temperature

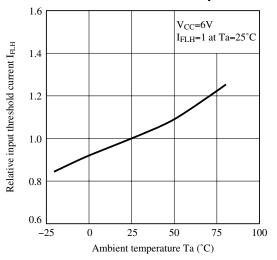


Fig.14 O₁ Low Level Output Voltage vs. Ambient Temperature

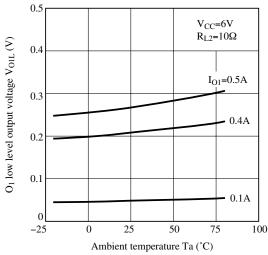


Fig.16 O₂ High Level Output Voltage vs. Ambient Temperature

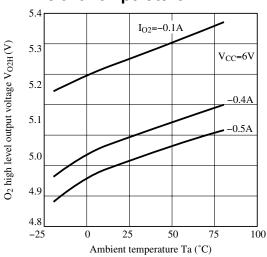


Fig.13 O₁ Low Level Output Voltage vs. O₁ Output Current

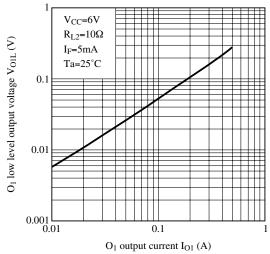


Fig.15 O₂ High Level Output Voltage vs. O₂ Output Current

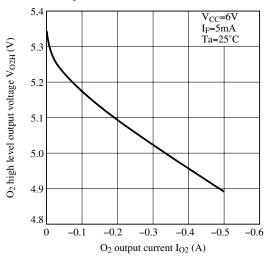


Fig.17 O₂ Low Level Output Voltage vs. O₂ Output Current

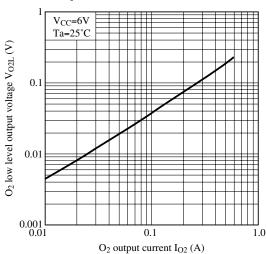




Fig.18 O₂ Low Level Output Voltage vs. Ambient Temperature

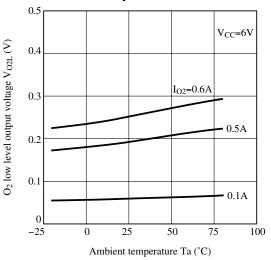


Fig.20 Low Level Supply Current vs. Supply Voltage

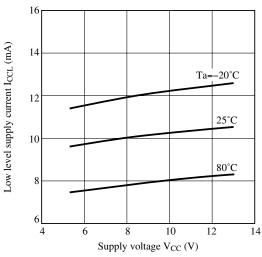


Fig.22 Propagation Delay Time vs.
Ambient Temperature

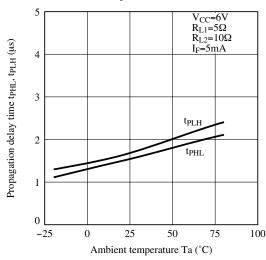


Fig.19 High Level Supply Current vs. Supply Voltage

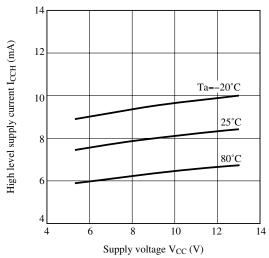


Fig.21 Propagation Delay Time vs. Forward Current

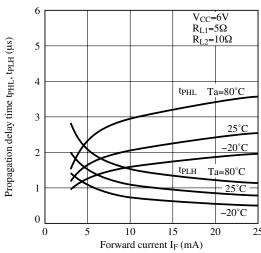


Fig.23 O₂ Peak Output Current vs. O₂ Low Level Output Voltage

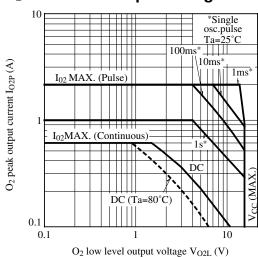
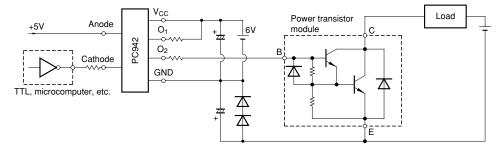




Fig.24 Application Circuit



This application circuit shows the general example of a circuit, and is not a disign guarantee for right operation.

Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.



■ Design Considerations

Notes about static electricity

Transistor of detector side in bipolar configuration may be damaged by static electricity due to its minute design.

When handling these devices, general countermeasure against static electricity should be taken to avoid breakdown of devices or degradation of characteristics.

Design guide

In order to stabilize power supply line, we should certainly recommend to connect a by-pass capacitor of $0.01\mu F$ or more between V_{CC} and GND near the device.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through IRED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of IRED.

The detector which is used in this device, has parasitic diode between each pins and GND.

There are cases that miss operation or destruction possibly may be occurred if electric potential of any pin becomes below GND level even for instant.

Therefore it shall be recommended to design the circuit that electric potential of any pin does not become below GND level.

This product is not designed against irradiation and incorporates non-coherent IRED.



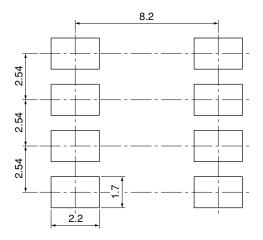
Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5years) into the design consideration.

Please decide the input current which become 2times of MAX. I_{FLH}.

Recommended Foot Print (reference)



(Unit:mm)

[☆] For additional design assistance, please review our corresponding Optoelectronic Application Notes.



■ Manufacturing Guidelines

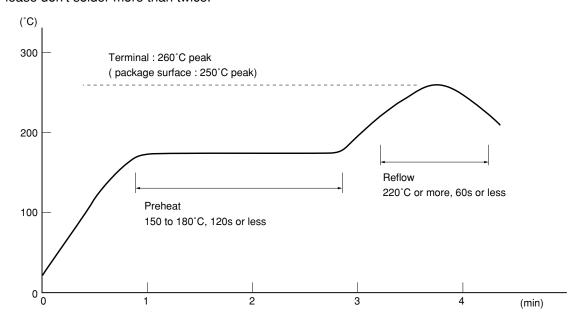
Soldering Method

Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.

Soldering should not exceed the curve of temperature profile and time.

Please don't solder more than twice.



Flow Soldering:

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s.

Preheating is within the bounds of 100 to 150°C and 30 to 80s.

Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C.

Please don't solder more than twice.

Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.



Cleaning instructions

Solvent cleaning:

Solvent temperature should be 45°C or below Immersion time should be 3minutes or less

Ultrasonic cleaning:

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials:

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this device.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.



■ Package specification

Sleeve package

Package materials

Sleeve: HIPS (with anti-static material)

Stopper: Styrene-Elastomer

Package method

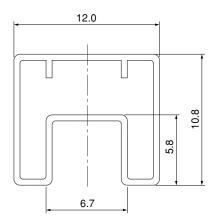
MAX. 50 pcs. of products shall be packaged in a sleeve.

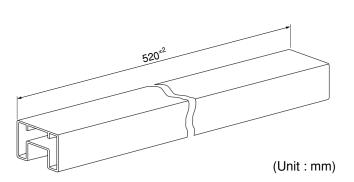
Both ends shall be closed by tabbed and tabless stoppers.

The product shall be arranged in the sleeve with its primary side mark on the tabless stopper side.

MAX. 20 sleeves in one case.

Sleeve outline dimensions







● Tape and Reel package

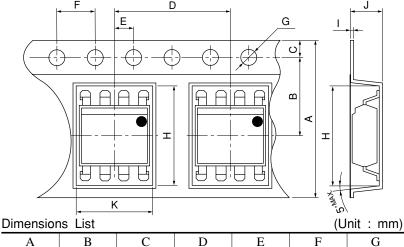
Package materials

Carrier tape: A-PET (with anti-static material)

Cover tape: PET (three layer system)

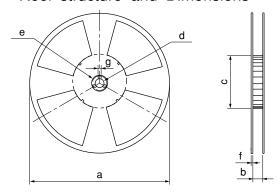
Reel: PS

Carrier tape structure and Dimensions



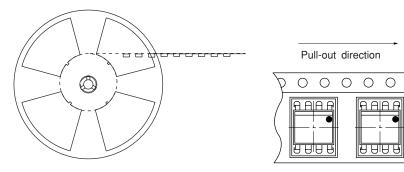
Difference List					(Onit : min)		
A	В	C	D	Е	F	G	
16.0 ^{±0.3}	7.5 ^{±0.1}	1.75 ^{±0.1}	12.0 ^{±0.1}	2.0 ^{±0.1}	4.0 ^{±0.1}	φ1.5 + 8.1	
Н	I	J	K				
10.4 ^{±0.1}	0.4 ^{±0.05}	$4.2^{\pm0.1}$	10.2 ^{±0.1}				

Reel structure and Dimensions



Dimensio	ns List	(Unit: mm)			
a	b	c	d		
330	17.5 ^{±1.5}	100±1.0	13±0.5		
e	f	g			
23±1.0	2.0±0.5	2.0±0.5			

Direction of product insertion



[Packing: 1 000pcs/reel]



■ Important Notices

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 - --- Office automation equipment
 - --- Telecommunication equipment [terminal]
 - --- Test and measurement equipment
 - --- Industrial control
 - --- Audio visual equipment
 - --- Consumer electronics
- (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection

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- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.
- (iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:
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 - --- Telecommunication equipment [trunk lines]
 - --- Nuclear power control equipment
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